

MBL1200F17F

Silicon N-channel IGBT 1700V F version

FEATURES

- * Soft switching behavior & low conduction loss :
 - Soft low-injection punch-through with trench gate IGBT
- * Low driving power due to low input capacitance advanced trench gate.
- * Low noise due to ultra soft fast recovery diode.
- * High Current rate Package.
- * Low $R_{th(j-c)}$ & low stray inductance.
- * RoHS

ABSOLUTE MAXIMUM RATINGS (T_C=25°C)

Item		Symbol	Unit	MBL1200F17F
Collector Emitter Voltage		V _{CES}	V	1,700
Gate Emitter Voltage		V _{GES}	V	±20
Collector Current	DC	I _C	A	1,200
	1ms	I _{CRM}		2,400
Forward Current (Free wheel Diode) (1)	DC	I _{F(FWD)}	A	150
	1ms	I _{FRM(FWD)}		300
Forward Current (Chopper Diode)	DC	I _{F(chopper)}	A	1,200
	1ms	I _{FRM(chopper)}		2,400
Operating Junction Temperature		T _{vj op}	°C	-50 ~ +150
Storage Temperature		T _{stg}	°C	-50 ~ +150
Isolation Voltage		V _{ISO}	V _{RMS}	4,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	N·m	2/15 (2)
	Mounting (M6)	-		6 (3)

Notes: (1) For reverse voltage protection (2) Recommended Value 1.8±0.2/ 15⁺⁰₋₃N·m (3) Recommended Value 5.5±0.5N·m

ELECTRICAL CHARACTERISTICS

1)IGBT+FWD

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	I _{CES}	mA	-	-	4	V _{CE} =1,700V, V _{GE} =0V, T _{vj} =25°C
			-	15	50	V _{CE} =1,700V, V _{GE} =0V, T _{vj} =150°C
Gate Emitter Leakage Current	I _{GES}	nA	-500	-	+500	V _{GE} =±20V, V _{CE} =0V, T _{vj} =25°C
Collector Emitter Saturation Voltage	V _{CE(sat)}	V	-	1.9	-	I _C =1,200A, V _{GE} =15V, T _{vj} =25°C
Gate Emitter Threshold Voltage	V _{GE(th)}	V	4.1	5.5	7.1	V _{CE} =10V, I _C =120mA, T _{vj} =25°C
Input Capacitance	C _{ies}	nF	-	63	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _{vj} =25°C
Internal Gate Resistance	R _{G(int)}	Ω	-	2.9	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _{vj} =25°C
Turn On Delay Time	t _{d(on)}	μs	-	0.78	-	V _{CC} =900V, I _C =1,200A
Rise Time	t _r		-	0.25	-	L _s =115nH (4)
Turn Off Delay Time	t _{d(off)}		-	1.7	-	R _{G(on/off)} =6.8/6.8Ω (4)
Fall Time	t _f		-	1.3	-	V _{GE} =±15V, T _{vj} =150°C
Forward Voltage Drop	V _F	V	-	1.5	-	I _F =150A, V _{GE} =0V, T _{vj} =25°C
			-	1.6	-	I _F =150A, V _{GE} =0V, T _{vj} =150°C
Turn On Loss	E _{on}	J/P	-	0.58	-	V _{CC} =900V, I _C =1,200A L _s =115nH (4)
Turn Off Loss	E _{off}	J/P	-	0.9	-	R _{G(on/off)} =6.8/6.8Ω (4) V _{GE} =±15V, T _{vj} =150°C
Stray inductance module	L _{SCE}	nH	-	20	-	Collector Main to Emitter Main
Thermal Impedance	IGBT	R _{th(j-c)}	K/W	-	0.02	Junction to case
	FWD			-	0.13	
Contact Thermal Impedance	R _{th(c-f)}	K/W	-	0.016	-	Case to fin (grease=1W/(m·K)), (at IGBT+FWD part)

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2) Chopper Diode

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Repetitive Reverse Current	I _{RRM}	mA	-	-	2	V _{CE} =1,700V, T _v =25°C
			-	8	-	V _{CE} =1,700V, T _v =150°C
Forward Voltage Drop (Between main terminals)	V _F	V	-	2.1	-	I _F =1,200A, T _v =25°C Measured at main terminals
			-	2.3	-	I _F =1,200A, T _v =150°C Measured at main terminals
Reverse Recovery Time	t _{rr}	μs	-	1.6	-	V _{CC} =900V, I _f =1,200A L _s =115nH (4)
Reverse Recovery Loss	E _{rr}	J/P	-	0.35	-	R _G (on/off)=6.8/6.8Ω (4) V _{GE} =±15V, T _v =150°C
Thermal Impedance	R _{th(j-c)}	K/W	-	-	0.03	Junction to case
Contact Thermal Impedance	R _{th(c-f)}	K/W	-	0.016	-	Case to fin(at Chopper Diode part)

Notes:(4) L_s and R_G are the test condition's values for evaluation of the switching times, not recommended value.

Please, determine the suitable R_G value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

* Please contact our representatives at order.

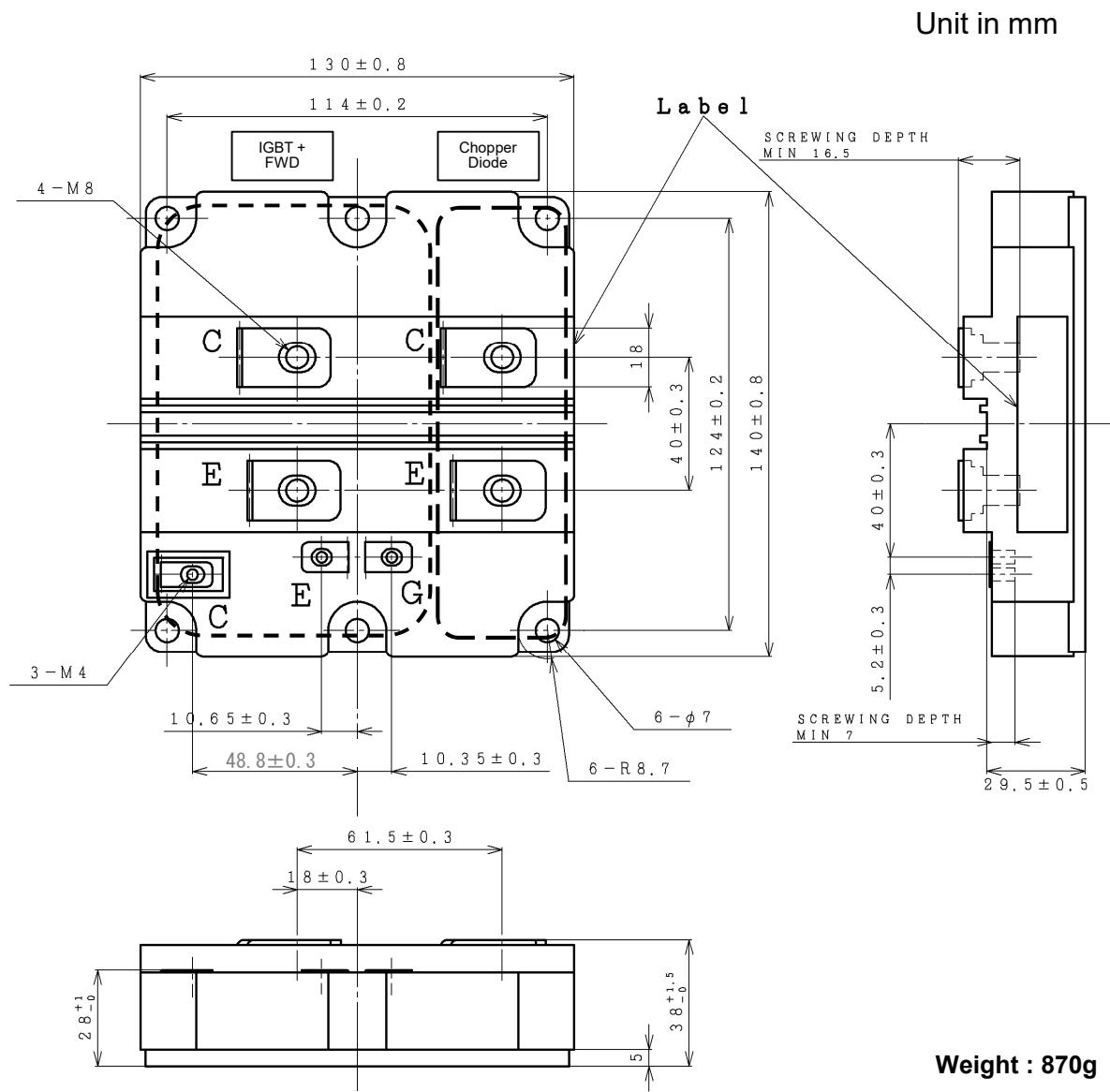
* For improvement, specifications are subject to change without notice.

* For actual application, please confirm this spec sheet is the newest revision.

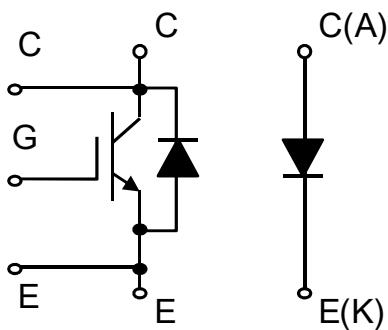
* ELECTRICAL CHARACTERISTIC items shown in above table are according to IEC 60747-2 and IEC 60747-9.

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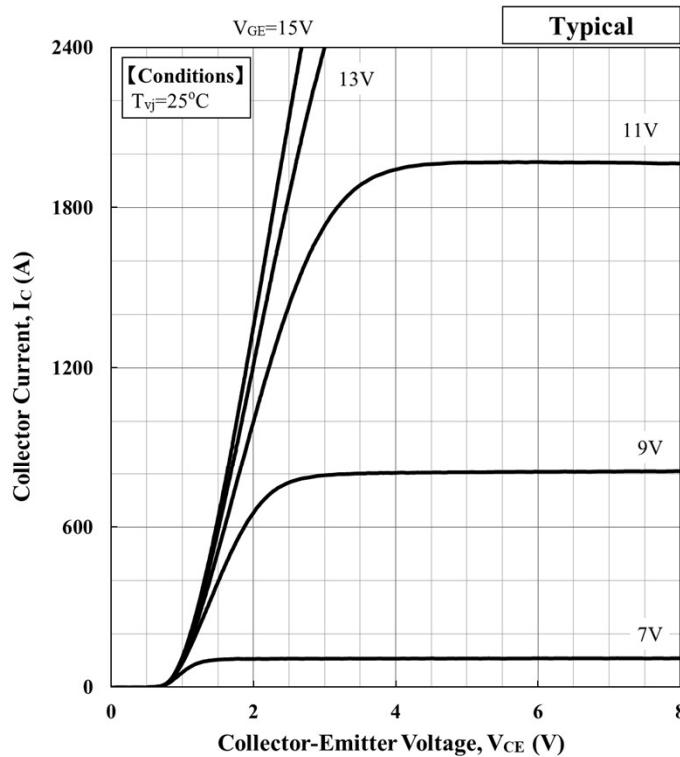
OUTLINE DRAWING



CIRCUIT DIAGRAM



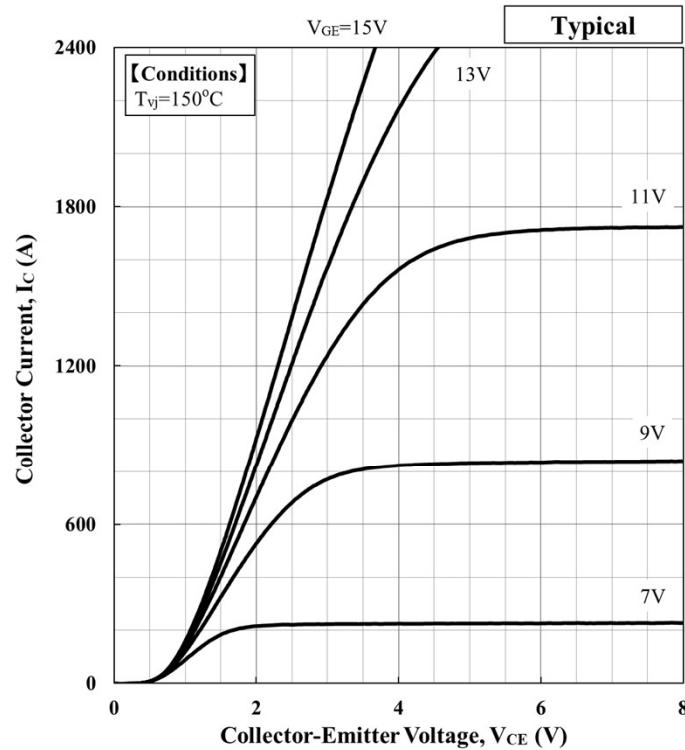
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$$V_{CE(sat)}[V] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	V _{GE} [V]	a ₃	a ₂	a ₁	a ₀
25	15	6.04.E-11	-2.92.E-07	1.09.E-03	9.07.E-01

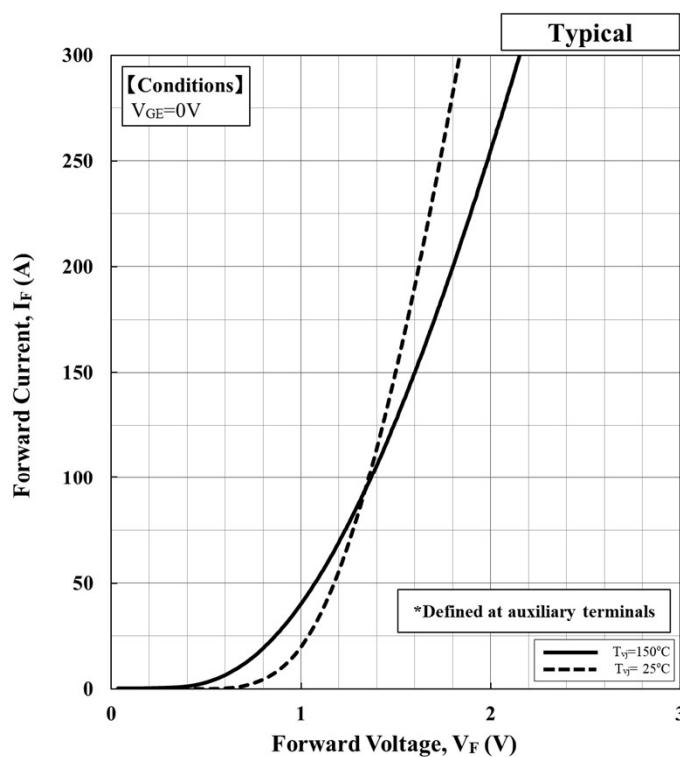
Collector Current vs. Collector Emitter Voltage



$$V_{CE(sat)}[V] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	V _{GE} [V]	a ₃	a ₂	a ₁	a ₀
150	15	9.52.E-11	-4.02.E-07	1.63.E-03	7.66.E-01

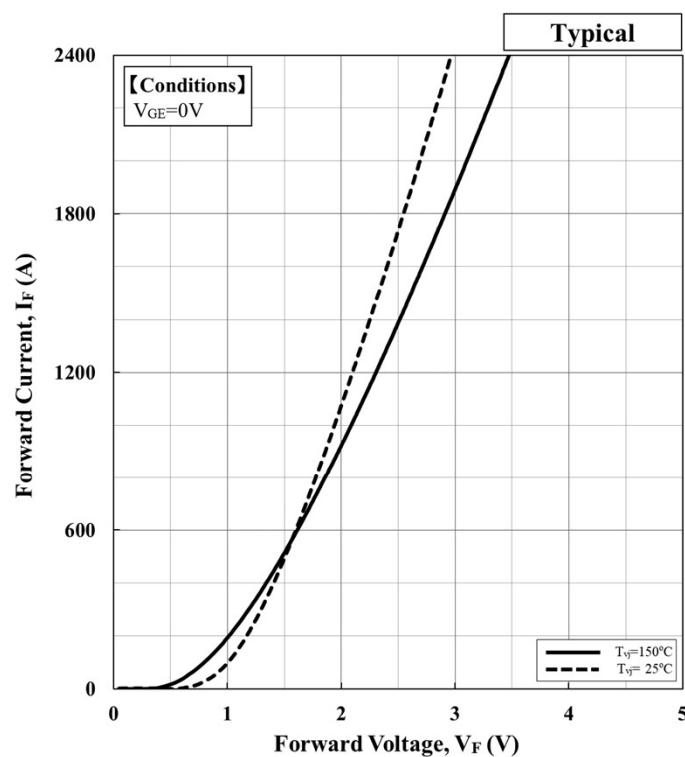
Collector Current vs. Collector Emitter Voltage



$$V_F[V] = a_3 \cdot |I_F|^3 + a_2 \cdot |I_F|^2 + a_1 \cdot |I_F| + a_0$$

Temp.[°C]	a ₃	a ₂	a ₁	a ₀
25	2.77.E-08	-1.86.E-05	6.27.E-03	8.91.E-01
150	3.98.E-08	-2.70.E-05	9.59.E-03	6.43.E-01

Forward Voltage of free-wheeling diode

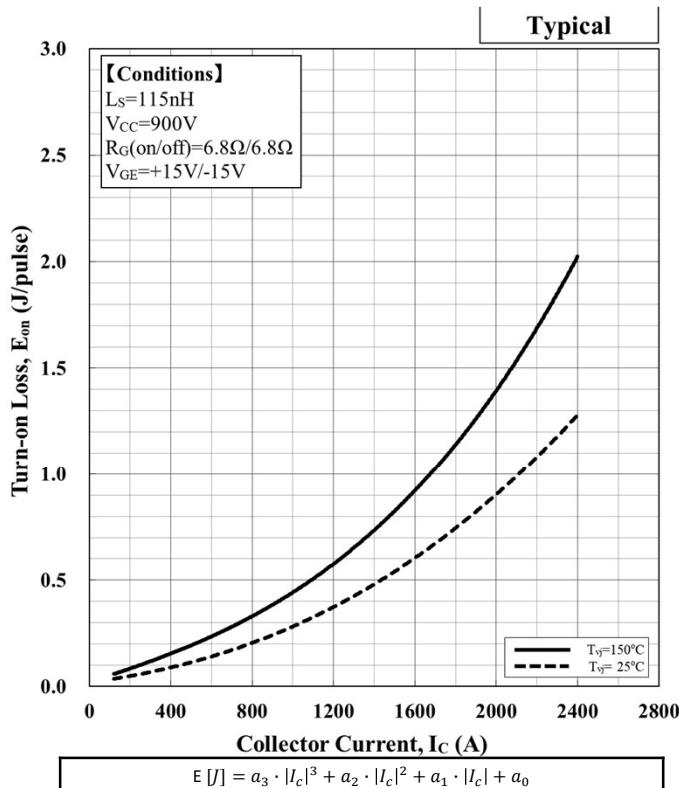


$$V_F[V] = a_3 \cdot |I_F|^3 + a_2 \cdot |I_F|^2 + a_1 \cdot |I_F| + a_0$$

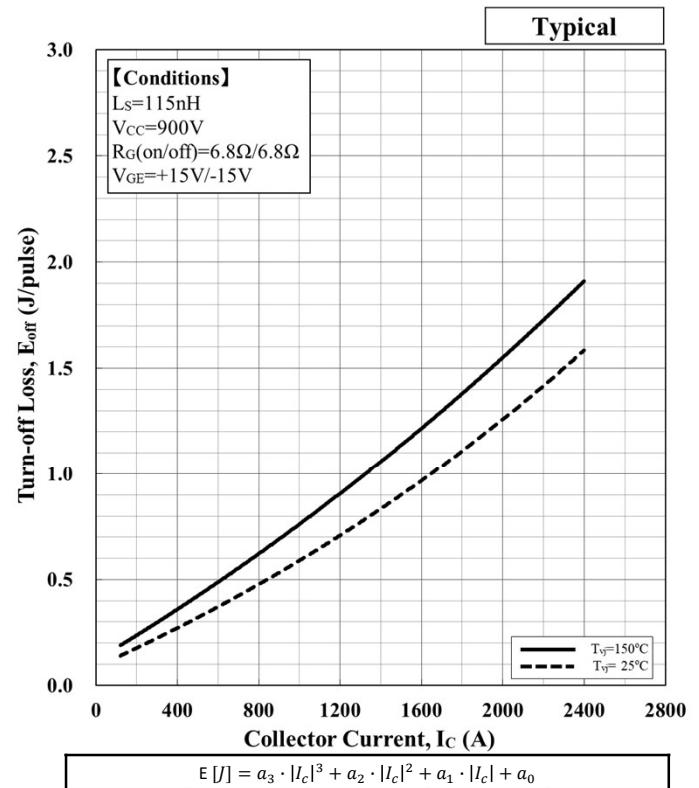
Temp.[°C]	a ₃	a ₂	a ₁	a ₀
25	5.93.E-11	-3.20.E-07	1.28.E-03	9.30.E-01
150	8.33.E-11	-4.62.E-07	1.80.E-03	6.70.E-01

Forward Voltage of Chopper diode

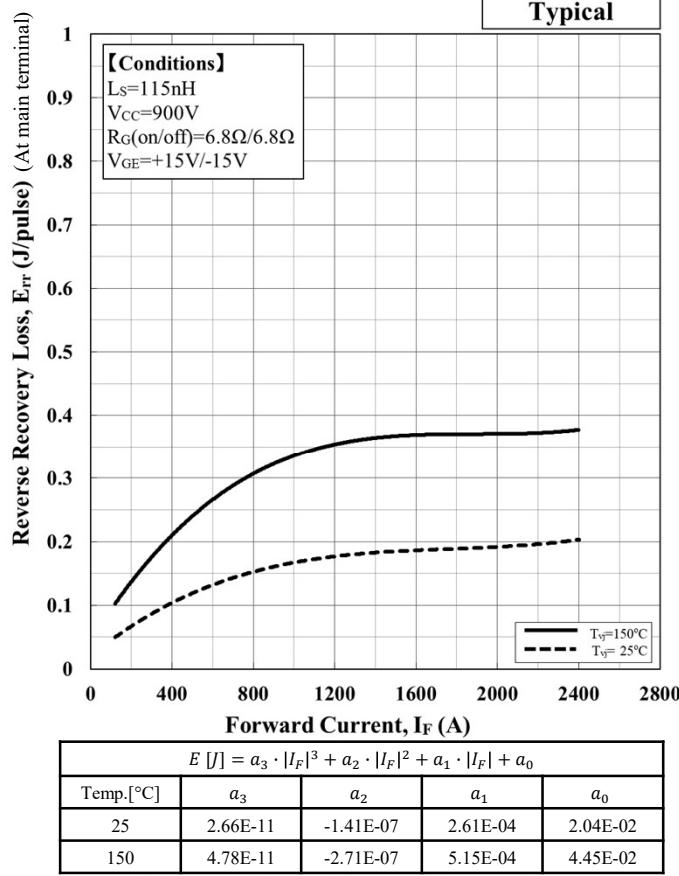
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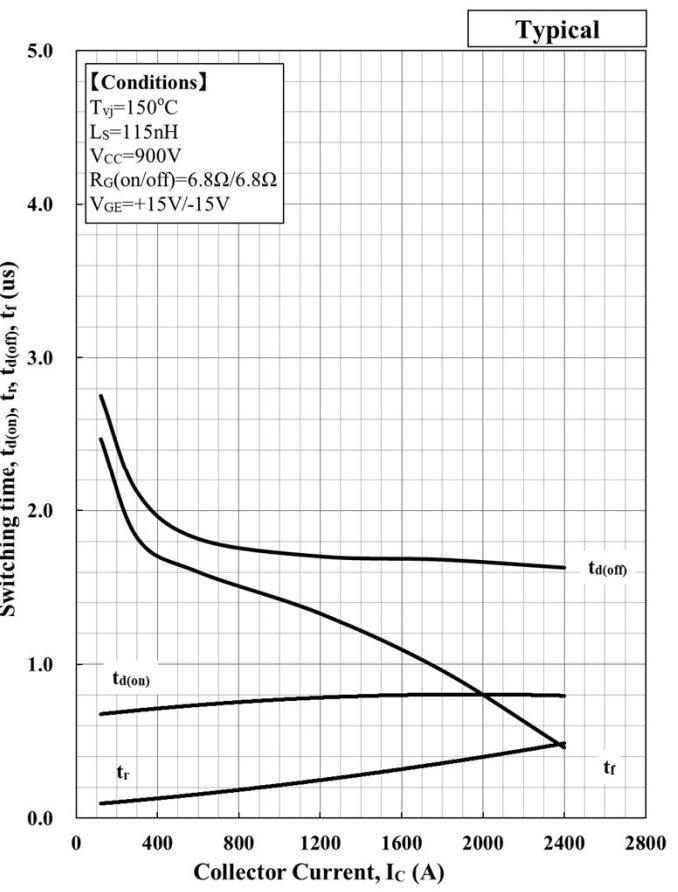
Turn-on loss vs. Collector current



Turn-off loss vs. Collector current

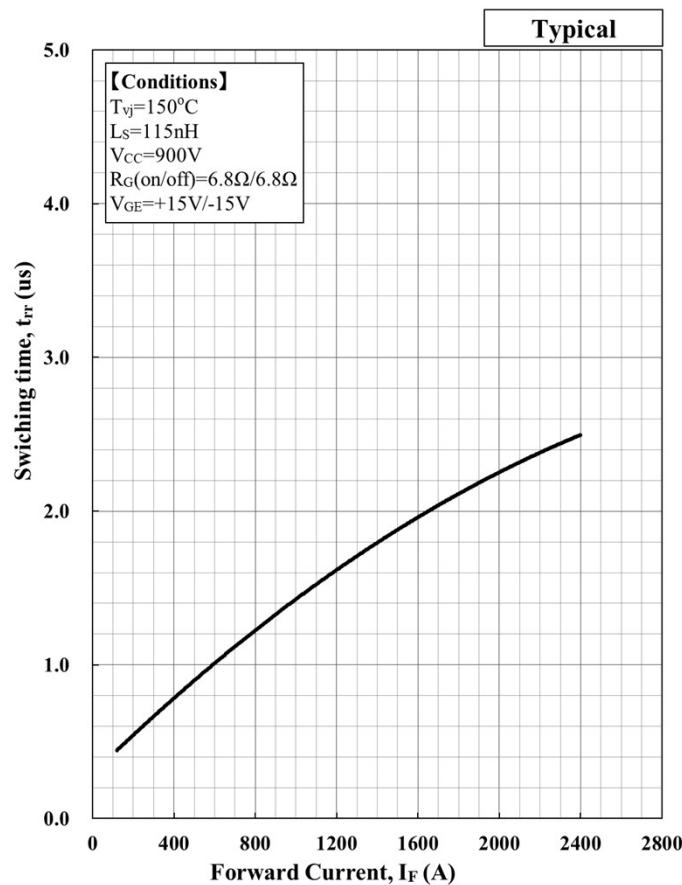


Recovery loss vs. Forward Current(Chopper Diode)



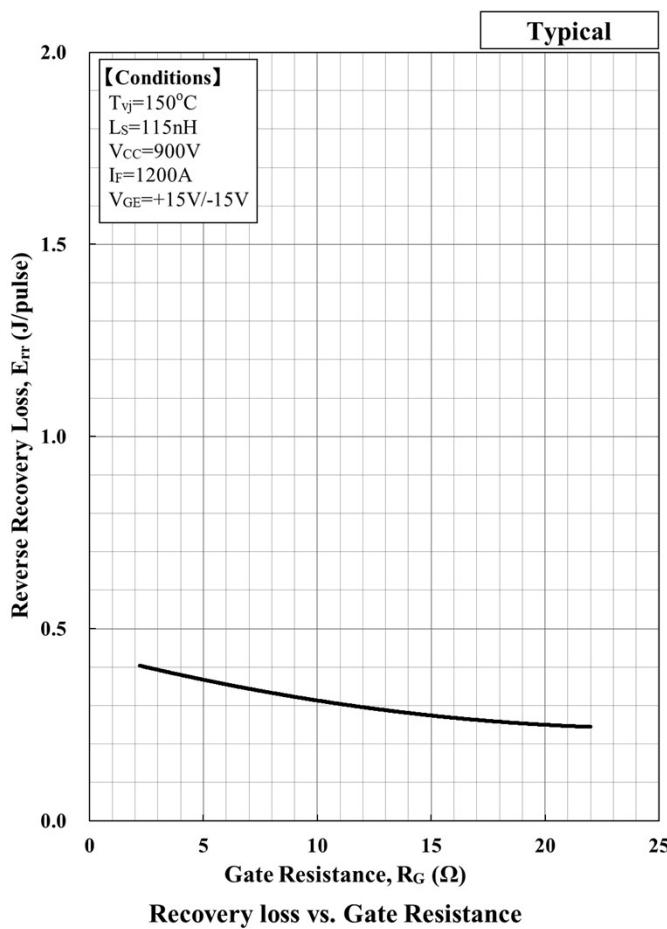
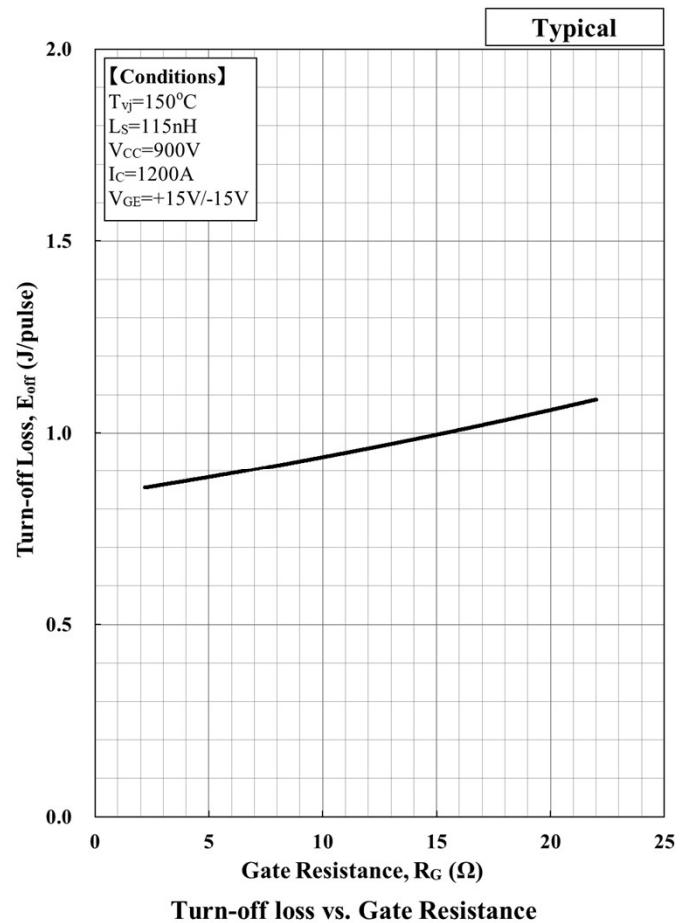
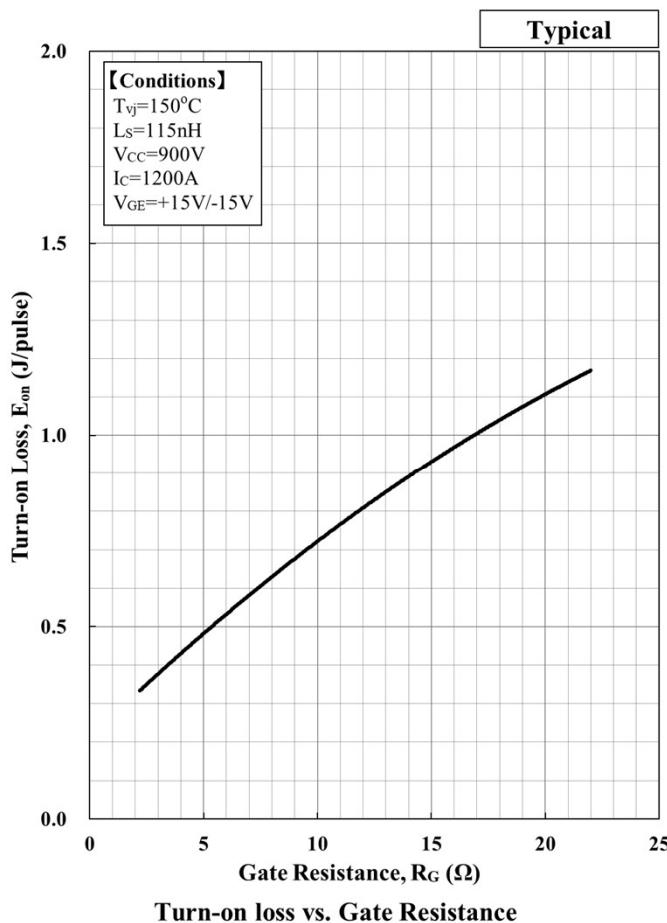
Switching time vs. Collector Current

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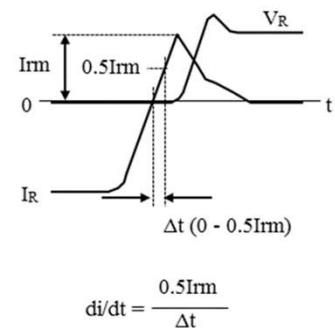
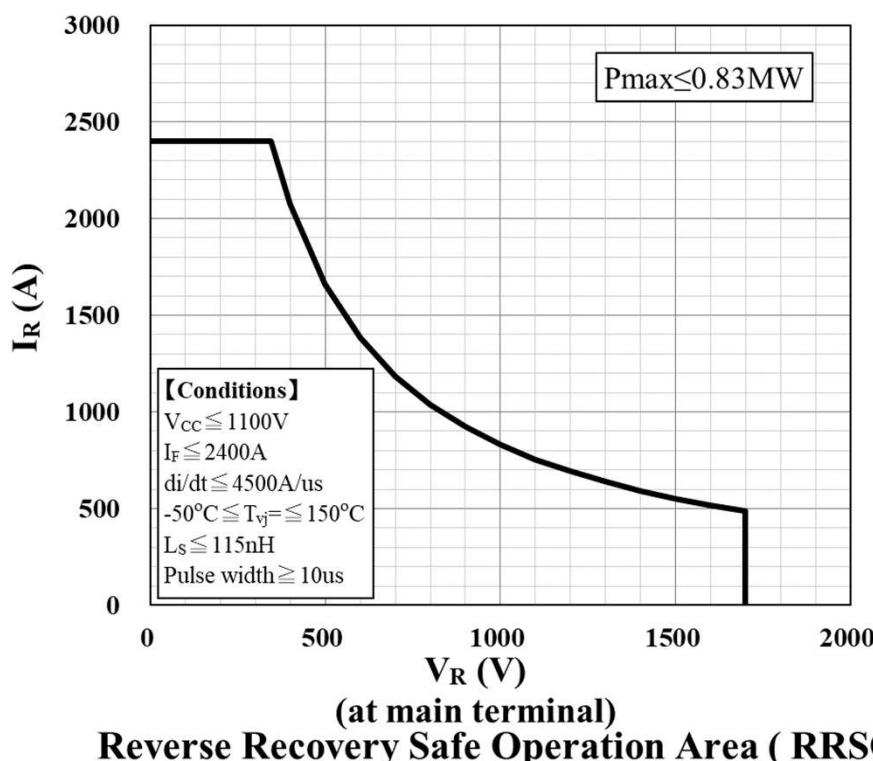
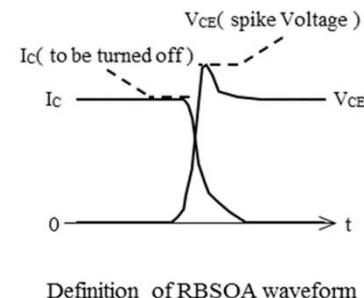
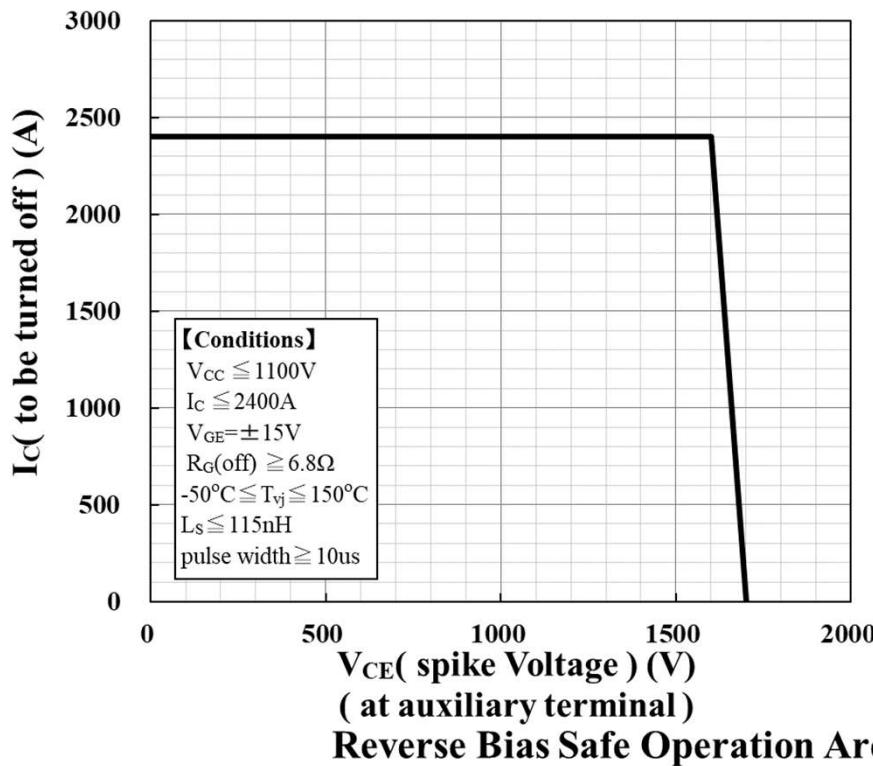


Switching time vs. Forward Current of chopper diode

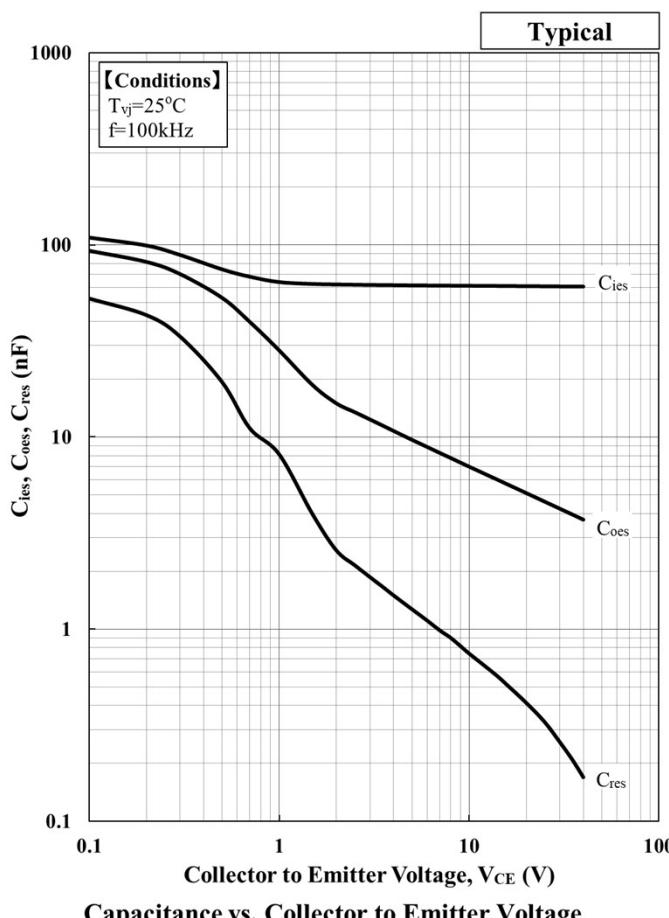
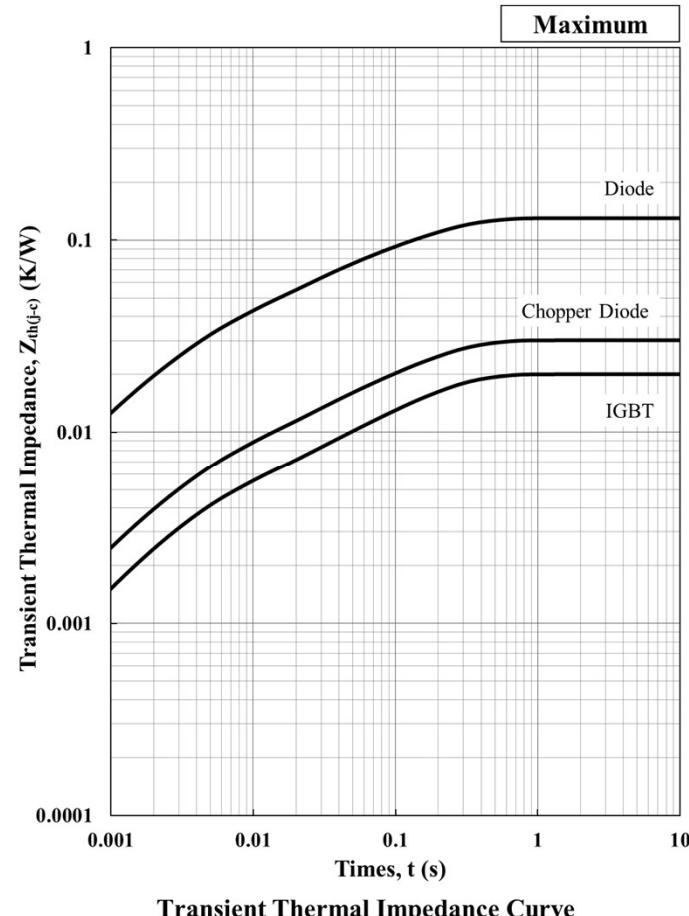
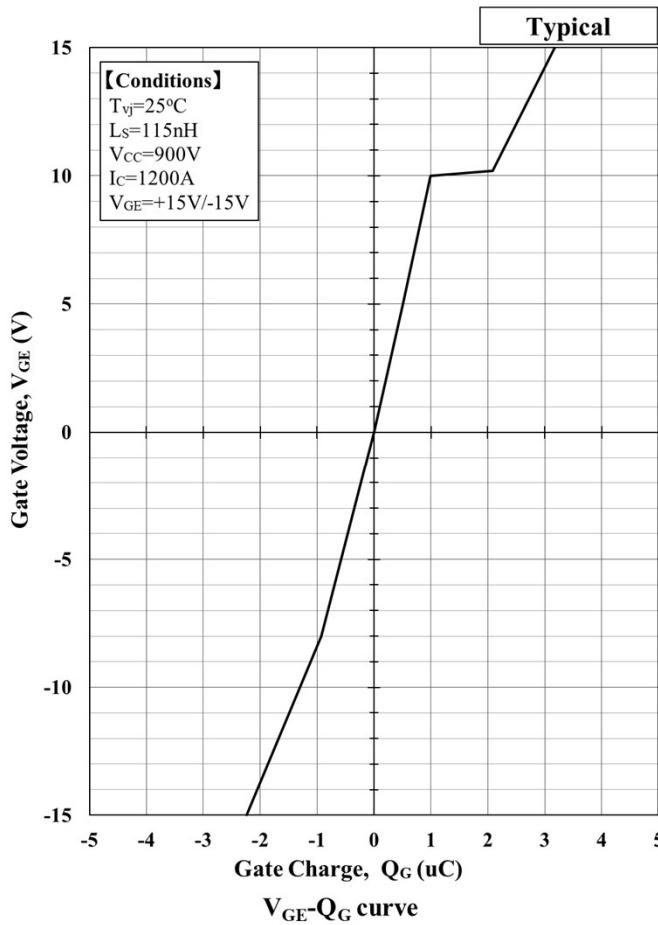
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Foster model lumped circuit constant

N	1	2	3	4	Unit
$R_{th, \text{IGBT}} [\text{n}]$	1.29E-02	3.34E-03	3.36E-03	4.62E-04	[K/W]
$C_{th, \text{IGBT}} [\text{n}]$	1.26E+01	7.45E+00	9.35E-01	1.17E+00	[J/K]
$R_{th, \text{Diode}} [\text{n}]$	6.80E-02	3.29E-02	2.39E-02	5.27E-03	[K/W]
$C_{th, \text{Diode}} [\text{n}]$	2.39E+00	7.56E-01	1.32E-01	1.03E-01	[J/K]
$R_{th, \text{Chopper Diode}} [\text{n}]$	1.79E-02	6.21E-03	5.06E-03	8.91E-04	[K/W]
$C_{th, \text{Chopper Diode}} [\text{n}]$	9.07E+00	4.00E+00	6.21E-01	6.07E-01	[J/K]

Cauer model lumped circuit constant

n	1	2	3	4	Unit
$R_{th, \text{IGBT}} [\text{n}]$	2.37E-03	3.08E-03	6.69E-03	7.88E-03	[K/W]
$C_{th, \text{IGBT}} [\text{n}]$	4.68E-01	6.27E-01	4.67E+00	1.30E+01	[J/K]
$R_{th, \text{Diode}} [\text{n}]$	1.78E-02	2.46E-02	4.38E-02	4.38E-02	[K/W]
$C_{th, \text{Diode}} [\text{n}]$	5.24E-02	9.55E-02	5.87E-01	2.79E+00	[J/K]
$R_{th, \text{Chopper Diode}} [\text{n}]$	3.67E-03	5.04E-03	1.01E-02	1.13E-02	[K/W]
$C_{th, \text{Chopper Diode}} [\text{n}]$	2.76E-01	4.28E-01	2.78E+00	9.94E+00	[J/K]

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